Power MOSFET

60 V, 16.5 m Ω , 38 A, Single N-Channel

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage	Drain-to-Source Voltage		V _{DSS}	60	V
Gate-to-Source Voltage			V _{GS}	±20	٧
Continuous Drain Cur-		T _C = 25°C	I _D	38	Α
rent R _{θJC} (Notes 1 & 3)	Steady	T _C = 100°C		27	
Power Dissipation R _{θJC}	State	T _C = 25°C	P_{D}	27	W
(Note 1)		T _C = 100°C		13	
Continuous Drain Cur-		T _A = 25°C	I _D	13	Α
rent $R_{\theta JA}$ (Notes 1, 2 & 3)	Steady	T _A = 100°C		9.0	
Power Dissipation R _{θJA}	State	T _A = 25°C	P_{D}	3.0	W
(Notes 1 & 2)		T _A = 100°C		1.5	
Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	I _{DM}	130	Α
Operating Junction and S	torage Te	mperature	T _J , T _{stg}	-55 to 175	°C
Source Current (Body Did	ode)		Is	28	Α
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, I _{L(pk)} = 2.0 A)		E _{AS}	93	mJ	
Lead Temperature for Sol (1/8" from case for 10 s)	dering Pu	rposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	5.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	50	

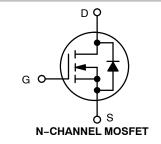
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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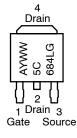
V _{(BR)DSS}	R _{DS(on)}	I _D
60 V	16.5 mΩ @ 10 V	38 A
	24.3 mΩ @ 4.5 V	30 /





DPAK CASE 369C STYLE 2

MARKING DIAGRAM & PIN ASSIGNMENT



A = Assembly Location

Y = Year

WW = Work Week

5C684L = Device Code

G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u>'</u>				•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	= 250 μΑ	60			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				27		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		$V_{DS} = 60 \text{ V}$	T _J = 125°C			250	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{G}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 20 μΑ	1.2		2.1	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _E	_O = 15 A		13.7	16.5	mΩ
		V _{GS} = 4.5 V, I	_D = 15 A		19.4	24.3	1
Forward Transconductance	9FS	V _{DS} = 5.0 V, I _I	_D = 15 A		30		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCES						
Input Capacitance	C _{iss}				700		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = V _{DS} = 25			300		1
Reverse Transfer Capacitance	C _{rss}	VDS - 20	, ,		13		
Total Gate Charge	Q _{G(TOT)}	V _{DS} = 48 V,	V _{GS} = 4.5 V		4.6		nC
			V _{GS} = 10 V		9.6		1
Threshold Gate Charge	Q _{G(TH)}		•		1.2		nC
Gate-to-Source Charge	Q _{GS}	Voc = 4.5 V. Vr	ne = 48 V.		2.0		
Gate-to-Drain Charge	Q_{GD}	$V_{GS} = 4.5 \text{ V}, V_{E}$ $I_{D} = 15$	Ä		1.2		1
Plateau Voltage	V _{GP}		ľ		2.9		V
SWITCHING CHARACTERISTICS (Note 5)	•				•	•	•
Turn-On Delay Time	t _{d(on)}				8.0		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{E}$	oc = 48 V		43		
Turn-Off Delay Time	t _{d(off)}	I _D = 15 A, R _G	$= 2.5 \Omega$		25		
Fall Time	t _f				40		1
DRAIN-SOURCE DIODE CHARACTERISTIC	S						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.9	1.2	V
-		$I_S = 0 \text{ V},$ $I_S = 15 \text{ A}$	T _J = 125°C		0.8		1
Reverse Recovery Time	t _{RR}		1		20		ns
Charge Time	ta	V00 = 0 V dle/dt	= 100 A/us		10		1
Discharge Time	tb	$V_{GS} = 0 \text{ V, dls/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 15 \text{ A}$			10		1
Reverse Recovery Charge	Q _{RR}				10		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

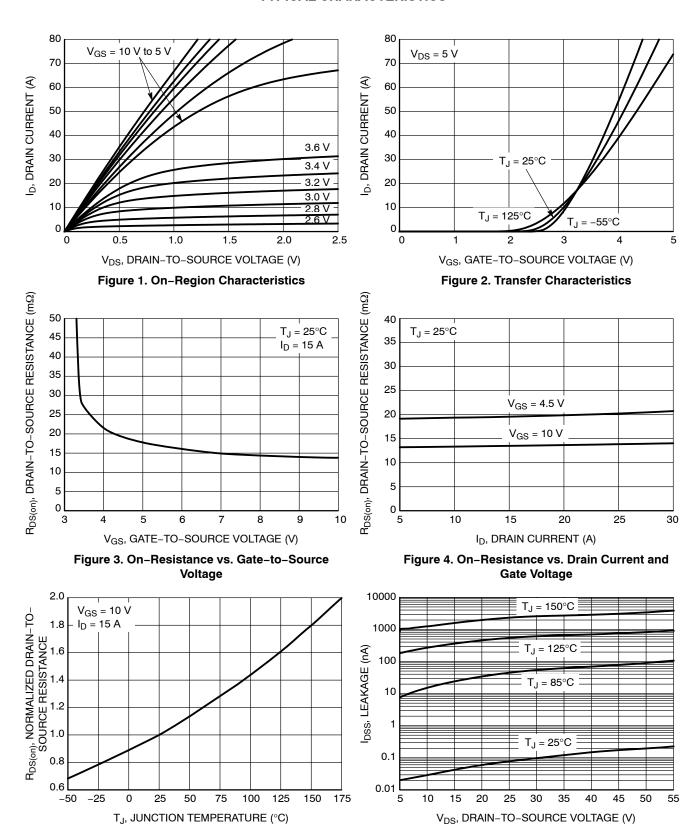


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

Temperature

TYPICAL CHARACTERISTICS

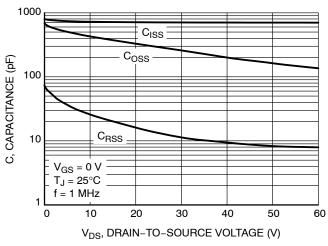


Figure 7. Capacitance Variation

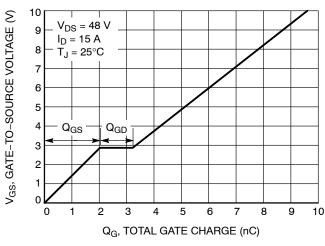


Figure 8. Gate-to-Source vs. Total Charge

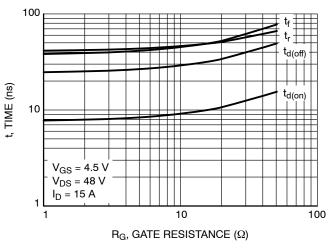


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

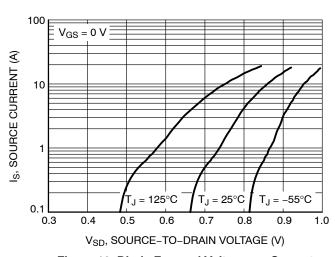


Figure 10. Diode Forward Voltage vs. Current

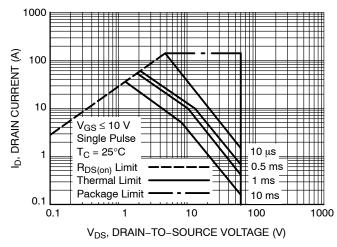


Figure 11. Maximum Rated Forward Biased Safe Operating Area

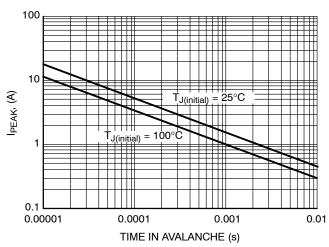


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

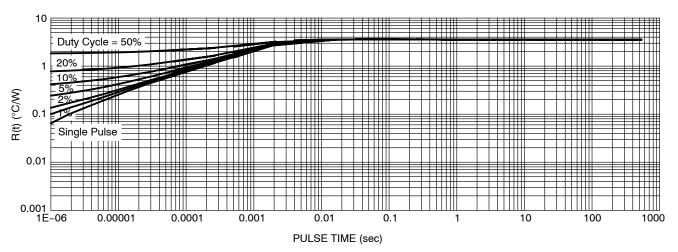


Figure 13. Thermal Response

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NVD5C684NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

DETAIL A ROTATED 90° CW



DPAK (SINGLE GAUGE)

CASE 369C ISSUE F

DATE 21 JUL 2015

- IOTES. 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-

- MENSIONS b3, L3 and Z.

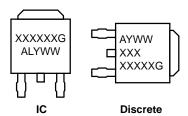
 Jimensions b And E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

 MENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114 REF		2.90	REF
L2	0.020	0.020 BSC 0.51		BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

GENERIC MARKING DIAGRAM*



XXXXXX = Device Code = Assembly Location Α = Wafer Lot L

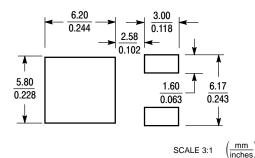
Υ = Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

SCALE 1:1 Α В L3 Ζ Ո DETAIL A NOTE 7 **BOTTOM VIEW** Cb2 е SIDE VIEW ⊕ 0.005 (0.13) M C **TOP VIEW** Z Ħ L2 GAUGE C SEATING PLANE **BOTTOM VIEW A1** ALTERNATE CONSTRUCTIONS

STYLE 1: PIN 1. BASE 2. COLLE 3. EMITTI 4. COLLE	ER 3. S		STYLE 3: PIN 1. ANOD 2. CATHO 3. ANOD 4. CATHO	E DDE E	STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE	STYLE 5: PIN 1. GATE 2. ANODE 3. CATHODE 4. ANODE
STYLE 6: PIN 1. MT1 2. MT2 3. GATE 4. MT2	STYLE 7: PIN 1. GATE 2. COLLECT 3. EMITTER 4. COLLECT	OR 2	E 8: I. N/C I. CATHODE I. ANODE II. CATHODE	2. 3.): ANODE CATHODE RESISTOR ADJUST CATHODE	STYLE 10: PIN 1. CATHODE 2. ANODE 3. CATHODE 4. ANODE

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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NEW STANDARD:	REF TO JEDEC TO-252	"CONTROLLED COPY" in red.		
DESCRIPTION:	DPAK SINGLE GAUGE SURFACE MOUNT		PAGE 1 OF 2	



DOCUMENT	NUMBER:
98AON10527	7D

PAGE 2 OF 2

ISSUE	REVISION	DATE				
0	RELEASED FOR PRODUCTION. REQ. BY L. GAN	24 SEP 2001				
Α	ADDED STYLE 8. REQ. BY S. ALLEN.	06 AUG 2008				
В	ADDED STYLE 9. REQ. BY D. WARNER.	16 JAN 2009				
С	ADDED STYLE 10. REQ. BY S. ALLEN.	09 JUN 2009				
D	RELABELED DRAWING TO JEDEC STANDARDS. ADDED SIDE VIEW DETAIL A. CORRECTED MARKING INFORMATION. REQ. BY D. TRUHITTE.	29 JUN 2010				
E	ADDED ALTERNATE CONSTRUCTION BOTTOM VIEW. MODIFIED DIMENSIONS b2 AND L1. CORRECTED MARKING DIAGRAM FOR DISCRETE. REQ. BY I. CAMBALIZA.	06 FEB 2014				
F	ADDED SECOND ALTERNATE CONSTRUCTION BOTTOM VIEW. REQ. BY K. MUSTAFA.	21 JUL 2015				

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